Se	eal	rch	No	tes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/772,741	SMITH ET AL.
Examiner	Art Unit
Pierre-Michel Bataille	2186

SEARCHED				
Class	Subclass	Date	Examiner	
711	173 ; 172 170 ; 147 105	2/17/2007	РМВ	
711	103			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			-	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
WEST SEARCH	2/17/2007	РМВ